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TECHNICAL REPORT

colour inside

Electronic display devices –
Part 3-2: Evaluation of optical characteristics – Mura

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CONTENTS

FOREWORD 4
INTRODUCTION 6
1 Scope 7
2 Normative references 7
3 Terms and definitions 7
4 Standard measuring conditions 8
4.1 Standard measuring conditions 8
4.1.1 Standard measuring environmental conditions 8
4.1.2 Standard measuring darkroom conditions 8
4.2 Light measuring device (LMD) 8
4.3 Measuring setup 9
4.4 Test signal 9
4.5 Measuring conditions 10
5 Standard evaluation method 10
5.1 Measurement data processing method 10
5.2 Measurement data processing flow 10
5.2.1 General 10
5.2.2 Median filter process 11
5.2.3 Transformation to opponent colour space from CIE XYZ 12
5.2.4 Convolution with the contrast sensitivity function (CSF) of the human visual system 12
5.2.5 Transformation to CIE XYZ from the opponent colour space 12
5.2.6 Transformation to CIELAB from CIE XYZ 12
5.2.7 a^* correction 13
5.3 Mura evaluation method 13
5.3.1 General 13
5.3.2 Lightness mura evaluation 13
5.3.3 Chroma mura evaluation 15
5.3.4 Mura evaluation 16
5.3.5 Measurement report 16
6 Actual example 17
6.1 General 17
6.2 Evaluation objects 17
6.3 Subjective evaluation 17
6.4 Evaluation by the method indicated inthis document using apparatus 18
6.5 Correlation between subjective evaluation and mura evaluation value 19
Annex A (informative) S-CIELAB model 20
A.1 General 20
A.2 S-CIELAB model 20
A.3 Spatial sensitivity function model (two-dimensional CSF model) 20
Annex B (informative) Type of mura 24
B.1 General 24
B.2 Classification of mura 24
Annex C (informative) Use case of a mura evaluation value 26
C.1 General 26

C.2 Example of a use case of a mura evaluation value 26
Annex D (informative) Various mura measurement methods 27
D.1 General 27
D.2 Comparison of mura evaluation standards 27
Bibliography 28

Figure 1 – Measuring layout 9
Figure 2 – Example of input signal 10
Figure 3 – Measurement data processing flow adopting the S-CIELAB model 11
Figure 4 – Concept diagram of real-space information integration 14
Figure 5 – 3 × 3 neighbourhood domain 15
Figure 6 – Evaluation objects in a dark room 17
Figure 7 – CSF filter images in opponent colour space 18
Figure 8 – Correlation of mura evaluation value and ITU-R subjective evaluation values 19
Figure A.1 – Flowchart of S-CIELAB calculation 20
Figure A.2 – Two-dimensional CSF model 21
Figure A.3 – Examples of the convolution of a two-dimensional CSF filter for illusion 23
Figure B.1 – Classification of mura by forms and/or causes 25

Table 1 – Example of reported criteria of two-dimensional LMD 9
Table 2 – Example of measurement results for a display screen uniformity 16
Table 3 – ITU-R quality and impairment scales 17
Table 4 – Subjective evaluation results 18
Table 5 – Evaluation results by apparatus 19
Table A.1 – Parameters for each axis of the opponent colour space 21
Table C.1 – Example of a use case of a mura evaluation value 26
Table C.2 – Example of subjects to evaluate 26
Table D.1 – Comparison chart of various mura measurement standards 27

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ELECTRONIC DISPLAY DEVICES –

Part 3-2: Evaluation of optical characteristics – Mura

FOREWORD

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IEC TR 62977-3-2, which is a technical report, has been prepared by IEC technical committee 110: Electronic display devices.

The text of this technical report is based on the following documents:

Enquiry draft	Report on voting
110/674A/DTR	110/701A/RVC

Full information on the voting for the approval of this technical report can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 62977 series, published under the general title *Electronic display devices*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

A bilingual version of this publication may be issued at a later date.

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INTRODUCTION

Electronic displays, for example liquid crystal displays (LCDs), plasma display panels (PDPs), organic light emission displays (OLEDs), and so on, have grown popular as displays for high-quality images. It is therefore increasingly important to measure the image quality of electronic displays. One factor degrading the image quality is non-uniformity, known as ‘mura’. The mura is classified into three types. The first is luminance mura, the second is colour mura. The third is called merely “mura” and includes luminance mura and colour mura simultaneously. It is impossible to recognize luminance mura and colour mura as completely separate objects.

Various measurement methods about luminance mura and colour mura have been reported in various academic conferences. There are also some standards for these mura. For example, uniformity of luminance and chromaticity are specified in IEC IEC 61747-30-1, SEMU (SEMI mura) is specified in SEMI D31-0213 and uniformity measurement is specified in IDMS ver.1.03 sec. 8. However there is no report which clearly provides the quantitative method for the mura that is called merely “mura” (see Annex D).

Therefore the majority of electronic display manufacturers are still using the limit sample for visual inspection.

This Technical Report, which intends to verify one mura measurement method, shows the detailed mura measurement method and its inspection experiment results.

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ELECTRONIC DISPLAY DEVICES –

Part 3-2: Evaluation of optical characteristics – Mura

1 Scope

This part of IEC 62977, which is a Technical Report, provides an optical measuring method of mura for electronic displays. It defines general measuring procedures for mura measurement and an evaluation method of electronic displays.

2 Normative references

The following documents, in whole or in part, are referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

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